INCH-POUND
MIL-PRF-83536A
AMENDMENT 7
15 April 2002
SUPERSEDING
AMENDMENT 6
19 October 2001

PERFORMANCE SPECIFICATION

RELAYS, ELECTROMAGNETIC, ESTABLISHED RELIABILITY, GENERAL SPECIFICATION FOR

This amendment forms a part of MIL-PRF-83536A, dated 21 March 1997, and is approved for use by all Departments and Agencies of the Department of Defense.

The attached insertable replacement pages as listed below are replacements for stipulated pages. When the new pages have been entered in the document, insert the amendment as the cover sheet to the specification.

| Replacement page | Page replaced | | |
|------------------|---------------|--|--|
| 15 | 15 | | |
| 16 | 16 | | |

PAGE 1

Paragraph 1.3, delete "(see 4.6)." and substitute "(see 4.6 and 6.1)."

PAGE 4

Paragraph 3.5.2, after first sentence add "Adjunct sealant shall only be applied to relays that have initially passed the gross leak seal requirement of this specification."

Paragraph 3.5.2, after c: add "After the cover has been welded to the header, no rework shall be performed that requires removal of this cover from the header."

PAGE 19

Add new paragraph 4.7.1.2:

"4.7.1.2 Internal foreign material control. The manufacturer shall, immediately preceding sealing, perform an audit on a weekly basis for the presence of foreign material within the relay package. Records shall be maintained to allow for verification of the performance of this audit. This audit may be satisfied during routine internal visual inspection. The magnification shall be 20X minimum. If the presence of any type of foreign material/contamination is discovered, the manufacturer shall perform the necessary analysis on a sample of suspect relays to determine the nature of the foreign material. The manufacturer shall then document the results of his investigation and corrective actions to eliminate the foreign material and shall maintain this information and make available to the qualifying activity when requested. The intent of this procedure is to require investigation and resolution of foreign material problems which do not have effective screening or detection methodology, but that could cause degradation and eventual failure of the relay. Repetitive findings without obvious improvements require escalation to Director of Manufacturing and Director of Quality Assurance, or their equivalents, to continue processing."

NOTE: Implementation of the above paragraph, 4.7.1.2, shall be no later than 180 days after the date of this amendment (6).

AMSC N/A 1 of 3 FSC 5945 DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.

PAGE 21

* Table VI, Visual inspection (external), Requirement paragraph, delete: "3.1, 3.29, 3.31" and substitute "3.1, 3.29, 3.30, 3.31"

Paragraph 4.7.3.2.1, third line: add "C7 and C8" between "C6" and "every".

PAGE 22

Table VII, C3 Life: Delete "(highest rated dc, 50,000 cycles)" and substitute "(highest rated dc, 50% of rated life)".

Table VII, C5: after "Rupture" add "(one dc and one ac)".

PAGE 23

Table VII, C7: after "Time current relay characteristics" add "(one dc and one ac)".

PAGE 25

Paragraph 4.8.5, delete and substitute: "4.8.5 <u>Dielectric withstanding voltage (see 3.10)</u>. Relays shall be tested as specified in 4.8.5.1 and in accordance with 4.8.5.2. Testing in accordance with 4.8.5.2 is not applicable to group A, group B, group C1, group C5, C6, C7 or C8 inclusive."

PAGE 26

Paragraph 4.8.7.3.2 <u>Contact voltage drop</u>. Add new subparagraph: "h. Test loads in Group A for relays rated greater than 10 amperes may be tested at 10 amperes. When testing at 10 amperes, the contact voltage drop shall be adjusted accordingly."

PAGE 36

Paragraph 4.8.18 <u>Life (see 3.23)</u>. After second sentence add: "At the option of the manufacturer double throw relays may have the normally open and normally closed contacts tested separately. If the normally open and normally closed contacts are tested separately an additional sample shall be provided for this option and both samples shall be required to meet all other tests in the test sequence."

PAGE 37

Paragraph 4.8.18.3, after "qualifying activity shall be used" add "(see 6.13)".

Paragraph 4.8.18.3, after last sentence: Delete "Cycling rate shall be 10 ±1 cycles per minute with equal "on" and "off" periods." (This reverses a change made by amendment 4.)

PAGE 39

Paragraph 4.8.20 first line: delete "300,000" and substitute "400,000".

PAGE 40

Paragraph 6.1, delete and substitute:

"6.1 Intended use. Relays conforming to this specification are intended for use in electronic and communication equipment. Their principal areas of application are for aircraft, missiles, spacecraft, and ground-support electronic and communication equipment. This does not preclude the use of these relays in other military applications.

<u>CAUTION</u>: The use of any coil voltage less than the rated coil voltage will compromise the operation of the relay.

<u>CAUTION</u>: Transfer relay contacts should not be used to ground load in one position and to 115 volt terminal in other position. Transfer relay contacts should not be used to transfer load between phases, nor between unsynchronized ac sources.

<u>CAUTION</u>: When latching relays are installed in equipment, the latch and reset coils should not be pulsed simultaneously. Coils should not be pulsed with less than the nominal coil voltage and the pulse width should be a minimum of three times the specified operate time of the relay. If these conditions are not followed, it is possible for the relay to be in the magnetically neutral position.

<u>CAUTION</u>: High in-rush currents caused by capacitive, inductive, motor, and lamp loads can erode or weld contacts reducing life leading to premature relay failure.

<u>CAUTION</u>: Failure rate level is determined under the life tests as specified in this specification. The failure rate may not be applicable under your application's load or environmental conditions.

Misapplication is one of the major causes of relay failures, users are cautioned against using a relay in an application for which it is not rated. Users are advised to contact the qualifying activity for assistance with application problems.

A helpful reference is the Engineers' Relay Handbook available from the National Association of Relay Manufacturers, 9459 N. Broadmore Road, Milwaukee, WI 53217, (414) 351-4548.

PAGE 45

Add paragraph "6.13 <u>Inductors</u>. Inductors meeting the requirements of MIL-I-81023, "Inductor, 28 V.D.C. Laboratory Test General Specification for" have been considered acceptable."

The margins of this amendment are marked with an asterisk to indicate where changes (additions, modifications, corrections, deletions) from the previous amendment were made. This was done as a convenience only and the Government assumes no liability whatsoever for any inaccuracies in these notations. Bidders and contractors are cautioned to evaluate the requirements of this document based on the entire content irrespective of the marginal notations and relationship to the last previous amendment.

Custodians: Preparing activity: Army - CR DLA - CC

Army - CR
Navy - EC
Air Force - 11

DLA - CC (Project 5945-1156)

Review activities:

Navy - AS NASA - NA

- 4.3.4 <u>Testing devices</u>. Devices used in the testing of relays shall not load the contacts above 10 mA resistive at 6 V dc or peak ac maximum open circuit unless otherwise specified herein.
- 4.3.5 <u>Mounting relays for ambient temperature tests</u>. When the relays are subjected to the testing specified in 4.8.19 (intermediate current), they may be mounted on a heat sink in accordance with the following:
 - a. Each relay may be attached by its normal mounting means to a 0.063 inch (1.59 mm) thick minimum, flat aluminum plate heat sink. The heat sink shall be designed to place every relay in the center of its own square space whose total surface area (both sides) is eight times the outside surface area of the relay, excluding mounting. Relays without mounts shall be held to the heat sink with a metal strap 0.250 inch (6.35 mm) wide by 0.015 inch (0.38 mm) maximum thickness. The heat sink assembly shall be suspended by twine or other nonheat conducting material. The leads shall not constitute a heat sink.
 - b. Chamber temperature shall be controlled to maintain the temperature at the specified ambient extremes (see 3.1).
- 4.3.6 <u>Methods of examination and test</u>. Application of coil power to relays under test shall be such that plus polarity is applied to the color coded terminal when applicable; or to the lower numbered terminal when color coding is not used. Testing of latching relays shall be repeated with the relay in each operated position.
- 4.3.7 <u>Tolerances</u>. Unless otherwise specified (see 3.1), all electrical, environmental, and mechanical parameters shall have a tolerance of ±10 percent.
- 4.3.8 <u>Alternate test equipment</u>. Test circuits and test equipment herein are intended to provide guidance to the relay manufacturer. Use of any alternate test circuits and / or test equipment shall be approved by the qualifying activity prior to use.
- 4.3.9 <u>Test equipment and inspection facilities</u>. The manufacturer shall establish and maintain a calibration system in accordance with ANSI/NCSL Z540-1, ISO-10012-1, or equivalent system as approved by the qualifying activity.
- 4.4 <u>Qualification inspection</u>. Qualification inspection shall be performed at a laboratory acceptable to the Government (see 6.3) on sample units produced with equipment and procedures normally used in production.
- 4.4.1 Qualification. Qualification shall be granted at the "L" or "M" FR initially and shall be based on results of the qualification inspection specified in table II. A certification of construction to the materials requirements of 3.4, and the interface and construction requirements of 3.5 shall accompany the submission of qualification inspection results to the qualifying activity.
- 4.4.1.1 <u>Sample size</u>. The number of relays to be subjected to qualification inspection shall be as specified in table II. The sample shall be selected from a production run and shall be produced with equipment or procedures normally used in production. The qualification sample shall be as defined in table II.
- 4.4.2 <u>Inspection routine</u>. Sample units shall be subjected to qualification inspection outlined in table II, in the order shown, except that group Q2 through group Q10 inclusive, may be conducted concurrently. All sample units shall be subjected to the inspections of Q1. These sample units shall then be divided into nine groups as specified in table II and subjected to the inspection specified for their particular group.
- 4.4.3 <u>Failures</u>. Failures in excess of those allowed in table II shall be cause for refusal to grant qualification approval.

Supersedes page 15 of MIL-PRF-83536A of 21 March 1997

TABLE II. Qualification inspection.

| | Г | | ı | 1 |
|--|---|--|---|----------------------------------|
| Inspection | Requirement paragraph | Test method paragraph | Number of sample units to be inspected | Number of failures allowed |
| Visual and mechanical inspection (internal) 1/ Run-in screening Internal moisture Solderability (3 sample units) 2/ Dielectric withstanding voltage Insulation resistance Electrical characteristics Visual and mechanical inspection (external) (dimensional check on 2 sample units only) Seal | 3.1 and 3.31 3.7 3.28 3.8 3.10 3.11 3.12 3.1, 3.29, 3.30, 3.31 3.9 | 4.8.1 4.8.2 4.8.23 4.8.3 4.8.5 4.8.6 4.8.7 4.8.1 | All — sample units | _ 0 |
| | 0.0 | 4.0.4 | | |
| Thermal shock Resistance to solvents Shock (specified pulse) Vibration (sinusoidal) Vibration (random) Acceleration Terminal strength Dielectric withstanding voltage Insulation resistance Electrical characteristics Seal | 3.13 3.26 3.14 3.15 3.15 3.16 3.17 3.10 3.11 3.12 3.9 | 4.8.8 4.8.21 4.8.9 4.8.10.1 4.8.10.2 4.8.11 4.8.12 4.8.5 4.8.6 4.8.7 4.8.4 | 4 | _ 1 |
| <u>Q3</u> | | | | |
| Resistance to soldering heat Salt spray or salt atmosphere Dielectric withstanding voltage Insulation resistance Electrical characteristics Seal | 3.18 3.19 3.10 3.11 3.12 3.9 | 4.8.13 4.8.14 4.8.5 4.8.6 4.8.7 4.8.4 | _ 4 | _ 1 |
| <u>Q4</u> | | | | |
| Overload (see table X) 3/ Life (rated resistive load and voltage from overload test) 3/ Dielectric withstanding voltage Insulation resistance Electrical characteristics | 3.20 3.23 3.10 3.11 3.12 | 4.8.15 4.8.18 4.8.5 4.8.6 4.8.7 | _ 4 | _ 1 |

See footnotes at end of table.

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